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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/722,815	11/26/2003	Cheol Kyu Bok	30205/39509	9353
4743	7590 07/30/2004		EXAMINER	
MARSHAL 6300 SEARS	L, GERSTEIN & BOI	WALKE, AMANDA C		
233 S. WAC			ART UNIT	PAPER NUMBER
CHICAGO,	IL 60606		1752	

DATE MAILED: 07/30/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

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Office Action Summary		Application No.	Applicant(s)	>				
		10/722,815	BOK ET AL.					
		Examiner	Art Unit					
		Amanda C Walke	1752					
Period fo	The MAILING DATE of this communication or Reply	appears on the cover sheet	with the correspondence address	i				
THE - Exte after - If the - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR RE MAILING DATE OF THIS COMMUNICATIO nsions of time may be available under the provisions of 37 CFF SIX (6) MONTHS from the mailing date of this communication. It is period for reply specified above is less than thirty (30) days, a period for reply is specified above, the maximum statutory per re to reply within the set or extended period for reply will, by state period by the Office later than three months after the med patent term adjustment. See 37 CFR 1.704(b).	N. R 1.136(a). In no event, however, may reply within the statutory minimum of t riod will apply and will expire SIX (6) Matute, cause the application to become	a reply be timely filed nirty (30) days will be considered timely. DNTHS from the mailing date of this communicat ABANDONED (35 U.S.C. § 133).	ion.				
Status								
1)[🛛	Responsive to communication(s) filed on 20	6 November 2003.						
		his action is non-final.						
3)		ce this application is in condition for allowance except for formal matters, prosecution as to the merits is sed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.						
Dispositi	on of Claims							
5)□ 6)⊠ 7)□	Claim(s) <u>1-21</u> is/are pending in the application 4a) Of the above claim(s) is/are without claim(s) is/are allowed. Claim(s) <u>1-21</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and	drawn from consideration.						
Applicati	on Papers							
10)⊠	The specification is objected to by the Exam The drawing(s) filed on <u>22 March 2004</u> is/are Applicant may not request that any objection to t Replacement drawing sheet(s) including the corr The oath or declaration is objected to by the	e: a) \boxtimes accepted or b) \square o he drawing(s) be held in abeyonection is required if the drawing	ance. See 37 CFR 1.85(a). g(s) is objected to. See 37 CFR 1.121	(d).				
Priority u	nder 35 U.S.C. § 119							
a)[Acknowledgment is made of a claim for foreion All b) Some * c) None of: 1. Certified copies of the priority docume 2. Certified copies of the priority docume 3. Copies of the certified copies of the priority docume application from the International Bure ee the attached detailed Office action for a least	ents have been received. ents have been received in riority documents have bee eau (PCT Rule 17.2(a)).	Application No n received in this National Stage					
Attachment	(s)							
2) Notice 3) Inform Paper	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449 or PTO/SB/(No(s)/Mail Date	Paper No	Summary (PTO-413) (s)/Mail Date Informal Patent Application (PTO-152)					

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DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-15, 20, and 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Wakiya et al (6416930).

Wakiya et al disclose a composition for lithographic anti-reflection coating, and a resist laminate using the composition. The reference teaches that "The water-soluble film-forming monomer is not specifically limited and includes any of water-soluble film-forming monomers as far as they are soluble in water and have transparency to irradiated light. A preferred water-soluble film-forming monomer can form a uniform coating by a conventional coating means such as spin coating, does not form an altered or deteriorated layer between a photoresist film even when the resulting coating solution is applied on the photoresist film, and can form a coating which is sufficiently transparent to an active ray or radiation, has a small absorption coefficient and has a high transparency.

Such water-soluble film-forming monomers include, but are not limited to, vinyl alcohol, vinylpyrrolidone, vinyl acetate, and other vinyl monomers; hydroxypropylmethylcellulose phthalate, hydroxypropylmethylcellulose acetate phthalate, hydroxypropylmethylcellulose acetate succinate, hydroxypropylmethylcellulose hexahydrophthalate, hydroxypropylmethylcellulose, hydroxypropylcellulose, hydroxypropylcellulose, cellulose acetate

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hexahydrophthalate, carboxymethyl cellulose, ethyl cellulose, methyl cellulose, and other cellulosic monomers; N,N-dimethylacrylamide, N,N-dimethylaminopropylmethacrylamide, N,N-dimethylaminopropylacrylamide, N-methylacrylamide, diacetone acrylamide, N,N-dimethylaminoethyl methacrylate, N,N-diethylaminoethyl methacrylate, N,N-diethylaminoethyl methacrylate, N,N-dimethylaminoethyl acrylate, acryloyl morpholine, acrylic acid, and other acrylic monomers.

Among these, vinyl monomers are preferred, of which vinylpyrrolidone is advantageous. Each of these water-soluble film-forming monomers can be used alone or in combination.

Such compounds represented by the formula (I) include, for example, perfluoroheptanoic acid and perfluorocctanoic acid. The compounds represented by the formula (II) include, for example, perfluoropropylsulfonic acid, perfluorocctylsulfonic acid, and perfluorodecylsulfonic acid. Specifically, perfluorocctanoic acid is commercially available under the trade name of EF-201, and perfluorocctylsulfonic acid is available under the trade name of EF-101, both as products of Tohkem Products Corporation, Japan. These compounds can be advantageously used. Among them, perfluorocctylsulfonic acid is specifically preferred as it has a high inhibitory activity against interference, a high solubility in water and is easy to adjust the pH of the resulting composition. Further, when the safety of the human body should be considered, perfluorocctanoic acid is preferred. Furthermore, when using perfluorocctanoic acid, in order to adjust pH, acidic compounds such as organic sulfonic acid or the like may be added, if necessary. Such organic sulfonic acid may be exemplified by p-toluenesulfonic acid, dodecylbenzene sulfonic acid and the like. "

Given the teachings of the reference, it would have been obvious to one of ordinary skill in the art to prepare the material of Wakiya et al choosing to employ N,N –dimethylacrylamide

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or vinylpyrrolidone as the water-soluble polymer of the antireflective layer, with reasonable expectation of achieving that is compatible with photorsist compositions.

3. Claims 16-19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Wakiya et al in view of Nishi et al (6,673,517).

Wakiya et al has been discussed above, however, the reference fails to teach the specific polymer claimed by the instant claims 16-19.

Nishi et al disclose a polymer comprising recurring units meeting the instant claim limitations. The reference teaches that the polymer results in excellent sensitivity, resolution, and etching resistance.

Given the teachings of the Nishi et al reference, it would have been obvious to one of ordinary skill in the art to prepare the material of Wakiya et al choosing to employ the layer of resist taught by Nishi et al to increase the sensitivity, resolution, and etch resistance, with with reasonable expectation of achieving that is compatible with photorsist compositions.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Amanda C Walke whose telephone number is 571-272-1337. The examiner can normally be reached on M-R 5:30-4.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mark Huff can be reached on 571-272-1385. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Amanda C Walke

Examiner
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ACW July 25, 2004